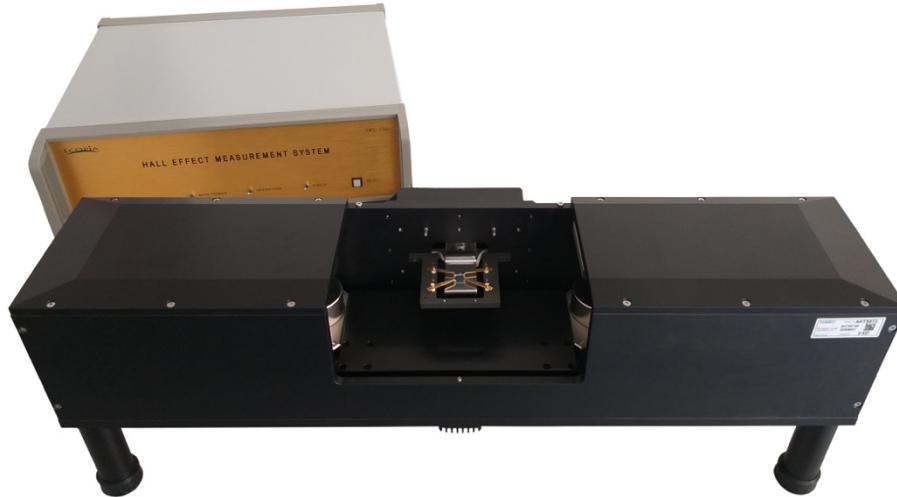


HMS5300/HMS5500

THERMAL HALL EFFECT MEASUREMENT SYSTEM



Hall Effect Measurement System is very useful for measuring Carrier Concentration, Mobility, Resistivity and Hall Coefficient that should be pre-checked in order to grasp the electrical specifications of semiconductor device. Therefore, it is essentially required system to understand the electrical characteristics of semiconductor device.

HMS series consist of constant current source , terminal conversion system by Van der Pauw technique, cold or hot temperature test system and magnetic flux density input system. So, it is well-established system that has all the things needed to Hall Effect Measurement System.

Hall effect Measurement Systems allow the ultra-fast characterization of several intrinsic parameters of conductive, semi-conductive materials. They use the Van Der Pauw method which is perfectly suited to thin film measurements and the Lorentz force in order to monitor around ten characteristics simultaneously under different environmental constraints.

Thanks to several module, the equipment permit to monitor the internal electrical parameters of a layer under different environmental constraints (variable temperature or variable magnetic field).

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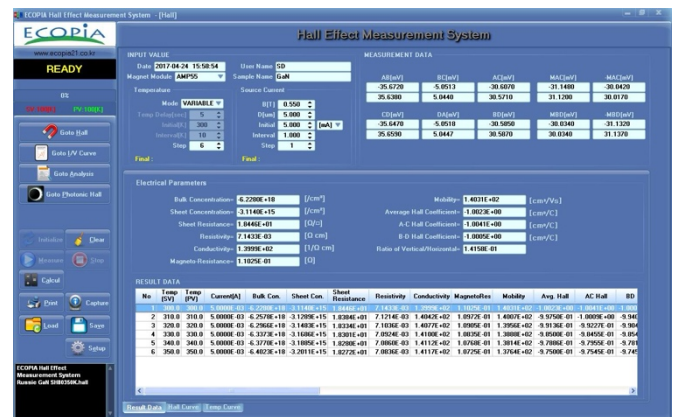
mainbody

A central unit controls the measurements and the temperature ramps. It integrates an internal SMU with a switch matrix to perform measurements using the Van der Pauw method. It has a communication board that will be connected to an external computer on which software will manage the parameters.

The software is the system's user interface. It consists of a measurement window and a contact test window. This "contact check" module verifies that all four contacts are ohmic and free of defects.

The measurement window allows users to enter measurement parameters (current, temperature steps) and initiate the test.

The software integrates all the necessary formulas and displays the calculated results of the sample parameters directly on an exportable table.



AHT55T



The sample is mounted on a thermal plate equipped with four gold-plated pogo pins for reliable electrical contact. These pogo pins are spring-loaded for easy positioning on the sample (no soldering required). Metallization (indium, silver, etc.) can further optimize contact depending on the material.

A magnet is part of this thermal module. It allows the sample holder to be inserted between the magnet to perform the Hall effect measurement. Two magnets are mounted on opposite side (N/S and S/N) on a motorized slider.

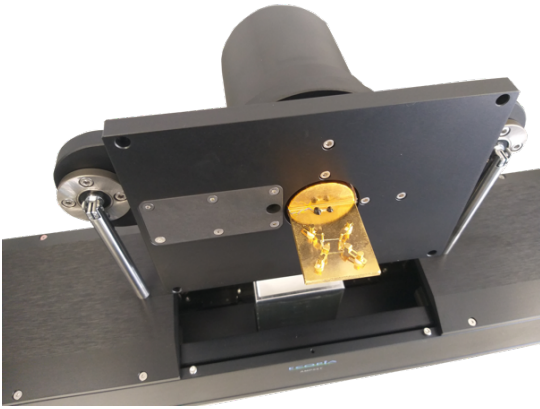
For high temperature, a chamber can be intalled around the sample and gas can be injected inside. This gas will protect the sample from oxidation.

Specifications:

Sample size	5 x 5mm to 20 x 20mm
Sample thickness	Max 2mm (other on request)
Probe	4 x gold plated pogo-pin
Mouvement	Semi-automatic
Sample material	SI, SiGe, SiC, GaAs, InGaAs, InPGaN, AlZnO, FeCdTe, ZnO...
Magnetic field	~ 0.5T
Magnet type	Ø50mm Neodym permanent
Pole gap	26mm
Temperature	300K to 570K with AHT55T3 300K to 770K with AHT55T5 77K to 350K with AMP55T/SH80350K Ambient or 77K with RTSK5000
Temperature management	Yes (not available for RTSK5000)
SMU	Internal
Current range	1nA to 20mA
Max voltage	10V
Voltage accuracy	+/- 2µV (0.02%) @ 10mV , +/- 2µV (0.2%) @ 1mV
Sheet resistance range	10 ⁻⁴ to 10 ⁷ Ω.cm
Concentration range	10 ⁷ to 10 ²¹ cm ⁻³
Mobility range	1 to 10 ⁷ cm ² /Vs
Software	Included (measurement, contact check, calculation, temperature and magnet sequences)
Data export	Yes (.csv)
Computer	Not included (Win10/11 compatible)
Communication	USB
Power	230VAC mono – 2A – 50Hz
Dimensions (w x l x h)	Mainbody: 435 x 415 x 140mm AHT55T: 645 x 210 x 270mm AMP55T: 645 x 220 x 100mm SH80350K: 290 x 135 x 190mm
Weight	Mainbody: 8.3kg AHT55T: 16.2kg AMP55T: 13.8kg SH80350K: 3.7kg



AMP55T/SH80350K module:



The system is compatible with cold applications. An additional module can be connected in place of the heating module. It consists of a dual motorized magnet, a heating plate, a sample holder, and a liquid nitrogen reservoir. It allows measurements between 77K and 350K.

The software has a function that imports data from both modules and thus plots a temperature response of your sample across the entire range of 77K to 570K/770K.

RTSK5000 kit:

This RTSK5000 kit is a substitute of the thermal SH80350K head. It allows measurements at ambient temperature or immersed in liquid nitrogen, without temperature regulation.

Its SPCB-21 sample holder is less fragile and can be easily replaced in case of damage.



Dual connector option:

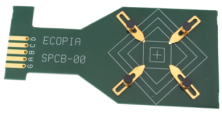

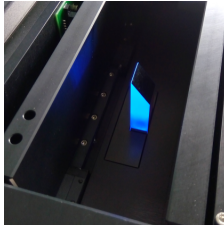



The dual connection option, allows the connection of both modules (hot and cold). A front switch permit to manually switch from modules. It avoids having to unplug one module to use another.

Model maker:

HMS5300/AHT55T3	300K to 570K
HMS5300/AMP55T/SH80350K HMS5300/AHT55T3/AMP55T/SH80350K	77K to 350K (compatible for high temp) 77K to 570K
HMS5500/AHT55T5	300K to 770K
HMS5500/AMP55T/SH80350K HMS5500/AHT55T5/AMP55T/SH80350K	77K to 350K (compatible for very high temp) 77K to 770K

Related products

<p>SPCB holder</p>  A green printed circuit board (PCB) with a central square area containing a crosshair and four gold-colored pads. The board has a multi-pin connector on the left side. Text on the board includes "ECOP1A" and "SPCB-00".	<p>Manual hall</p>  A setup for manual measurement, featuring a laptop displaying a software interface, a white electronic device, and a small white component.	<p>Photonic hall</p>  A close-up view of a photonic measurement setup, showing a blue light source and various optical components within a dark enclosure.	<p>Vacuum hall</p>  A complex, multi-component measurement setup housed in a metal enclosure, likely a vacuum chamber, with various cables and connectors.
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